

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/766,588	HOSHINO ET AL.	
	Examiner	Art Unit	
	Huan H. Tran	2861	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
347	197	7/7/2005	HHT
400	120.16	7/7/2005	HHT